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SEMICONDUCTOR

# ISL9R3060G2, ISL9R3060P2

# 30A, 600V Stealth™ Diode

## **General Description**

The ISL9R3060G2 and ISL9R3060P2 are Stealth™ diodes optimized for low loss performance in high frequency hard switched applications. The Stealth<sup>TM</sup> family exhibits low reverse recovery current ( $I_{RRM}$ ) and exceptionally soft recovery under typical operating conditions.

This device is intended for use as a free wheeling or boost diode in power supplies and other power switching applications. The low  ${\sf I}_{RRM}$  and short  ${\sf t}_a$  phase reduce loss in switching transistors. The soft recovery minimizes ringing, expanding the range of conditions under which the diode may be operated without the use of additional snubber circuitry. Consider using the Stealth™ diode with an SMPS IGBT to provide the most efficient and highest power density design at lower cost.

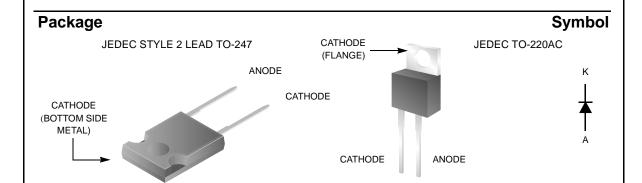
Formerly developmental type TA49411.

## Features

- Fast Recovery ......t<sub>rr</sub> < 35ns
- Operating Temperature ..... 175°C
- Avalanche Energy Rated

## **Applications**

- Switch Mode Power Supplies
- Hard Switched PFC Boost Diode
- UPS Free Wheeling Diode
- Motor Drive FWD
- SMPS FWD
- Snubber Diode



# Device Maximum Ratings T<sub>C</sub>= 25°C unless otherwise noted

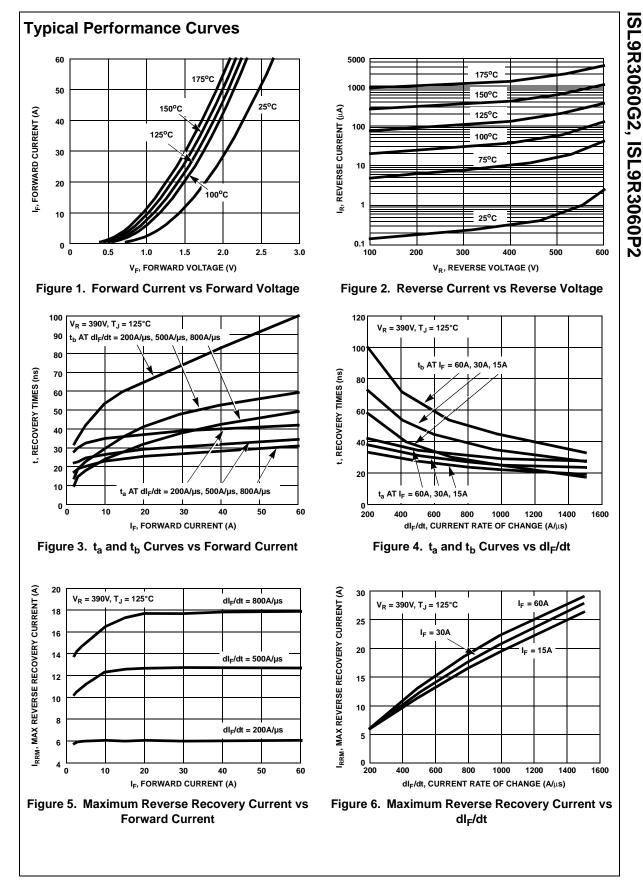
Symbol	Parameter	Ratings	Units
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage	600	V
V <sub>RWM</sub>	Working Peak Reverse Voltage	600	V
V <sub>R</sub>	DC Blocking Voltage	600	V
I <sub>F(AV)</sub>	Average Rectified Forward Current	30	Α
I <sub>FRM</sub>	Repetitive Peak Surge Current (20kHz Square Wave)	70	Α
I <sub>FSM</sub>	Nonrepetitive Peak Surge Current (Halfwave 1 Phase 60Hz)	325	Α
PD	Power Dissipation	200	W
E <sub>AVL</sub>	Avalanche Energy (1A, 40mH)	20	mJ
Г <sub>Ј</sub> , Т <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 175	°C
т <sub>L</sub>	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10s	300	ാം
T <sub>PKG</sub>	Package Body for 10s, See Techbrief TB334	260	°C

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Device	Marking	Device	Package	Tape Width			Quar	itity
R30	R3060G2 ISL9R3060G2		TO-247	-			-	
R30			TO-220AC	-			-	
Electric	al Char	° <b>acteristics</b> ⊤ <sub>C</sub> = 25°C u	nless otherwise	noted				
Symbol		Parameter	Test	Conditions	Min	Тур	Max	Units
Off State	Characte	ristics						
I <sub>R</sub>	1			$T_{C} = 25^{\circ}C$	-	-	100	μA
ĸ			K	$T_{\rm C} = 125^{\circ}{\rm C}$	-	-	1.0	mA
n State	Characte	ristics	I	0				
V <sub>F</sub>		Instantaneous Forward Voltage		$T_{\rm C} = 25^{\circ}{\rm C}$	-	2.1	2.4	V
I			I <sub>F</sub> = 30A	T <sub>C</sub> = 125°C	-	1.7	2.1	V
			1	U U				
ynamic	Characte	ristics						
CJ	Junction C	apacitance	$V_{R} = 10V, I_{F} = 0$	0A	-	120	-	pF
witching	g Characte	eristics						
t <sub>rr</sub>	Reverse R	ecovery Time	$\begin{array}{c c c c c c c c c c c c c c c c c c c $		-	27	35	ns
					-	36	45	ns
t <sub>rr</sub>	Reverse R	ecovery Time			-	36	-	ns
I <sub>RRM</sub>	Maximum	Reverse Recovery Current			-	2.9	-	Α
Q <sub>RR</sub>	Reverse R	ecovery Charge			-	55	-	nC
t <sub>rr</sub>	Reverse R	ecovery Time			-	110	-	ns
S	-	actor (t <sub>b</sub> /t <sub>a</sub> )			-	1.9	-	
I <sub>RRM</sub>	Maximum	Reverse Recovery Current			-	6	-	A
Q <sub>RR</sub>		ecovery Charge			-	450	-	nC
t <sub>rr</sub>		ecovery Time			-	60	-	ns
S		Softness Factor ( $t_b/t_a$ ) $d_{IF}/dt = 1000A/\mu s$ , Maximum Payoro Pacovor Current V <sub>B</sub> = 390V,		-	1.25	-		
I <sub>RRM</sub>		Reverse Recovery Current	$T_{C} = 125^{\circ}C$		-	21	-	A
Q <sub>RR</sub>		ecovery Charge				730	-	nC
dl <sub>M</sub> /dt		di/dt during t <sub>b</sub>			-	800	-	A/µs
	Characte	eristics esistance Junction to Case					0.75	°C/W
		esistance Junction to Ambient	TO-247			-	30	°C/W
R <sub>0JA</sub>								°C/W
R <sub>θJA</sub>	Thermal R	esistance Junction to Ambient	TO-220		-	-	62	°(

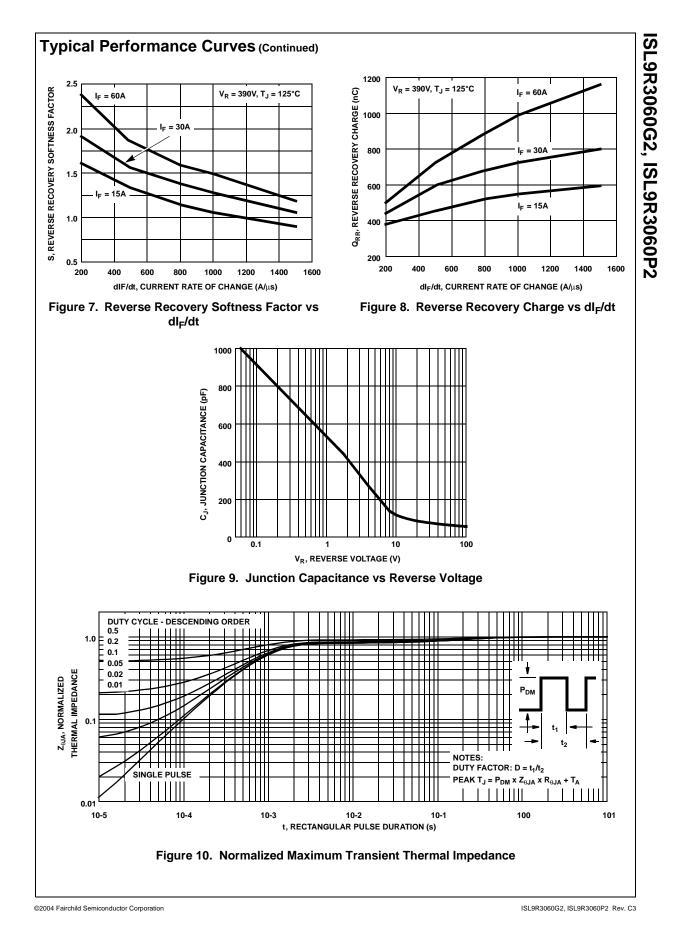
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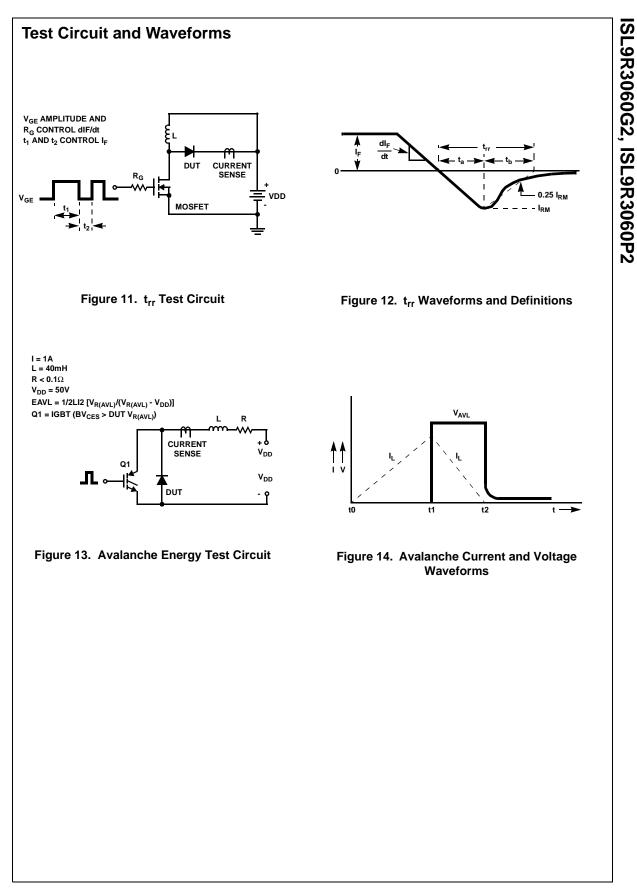
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The Power Franchise <sup>®</sup>		PACMAN <sup>™</sup>	SPM™	
Programmable Active Droop <sup>™</sup>		POP <sup>™</sup>	Stealth™	

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